Dual Low Bias Current Precision Operational Amplifier

OP297

FEATURES

Low offset voltage: 50 µV maximum
Low offset voltage drift: 0.6 µV/°C maximum
Very low bias current: 100 pA maximum
Very high open-loop gain: 2000 V/mV minimum
Low supply current (per amplifier): 625 µA maximum
Operates from ±2 V to ±20 V supplies
High common-mode rejection: 120 dB minimum

APPLICATIONS

Strain gage and bridge amplifiers
High stability thermocouple amplifiers
Instrumentation amplifiers
Photocurrent monitors
High gain linearity amplifiers
Long-term integrators/filters
Sample-and-hold amplifiers
Peak detectors
Logarithmic amplifiers
Battery-powered systems

GENERAL DESCRIPTION

The OP297 is the first dual op amp to pack precision performance into the space saving, industry-standard 8-lead SOIC package. The combination of precision with low power and extremely low input bias current makes the dual OP297 useful in a wide variety of applications.

Precision performance of the OP297 includes very low offset, under 50 µV, and low drift, below 0.6 µV/°C. Open-loop gain exceeds 2000 V/mV, ensuring high linearity in every application.

Errors due to common-mode signals are eliminated by the common-mode rejection of over 120 dB, which minimizes offset voltage changes experienced in battery-powered systems. The supply current of the OP297 is under 625 µA.

The OP297 uses a super-beta input stage with bias current cancellation to maintain picoamp bias currents at all temperatures. This is in contrast to FET input op amps whose bias currents start in the picoamp range at 25°C, but double for every 10°C rise in temperature, to reach the nanoamp range above 85°C. Input bias current of the OP297 is under 100 pA at 25°C and is under 450 pA over the military temperature range per amplifier. This part can operate with supply voltages as low as ±2 V.

PIN CONFIGURATION

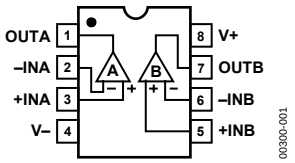

Figure 1.

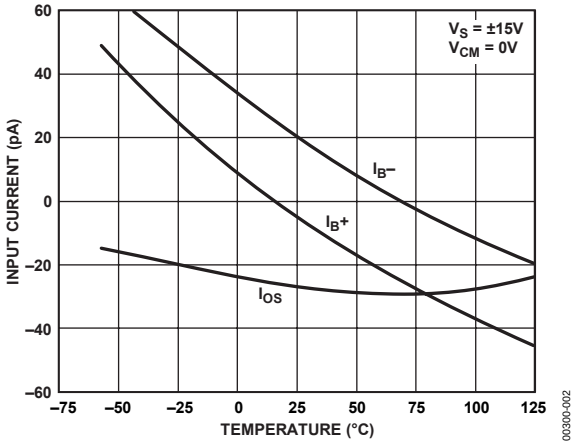

Figure 2. Low Bias Current over Temperature

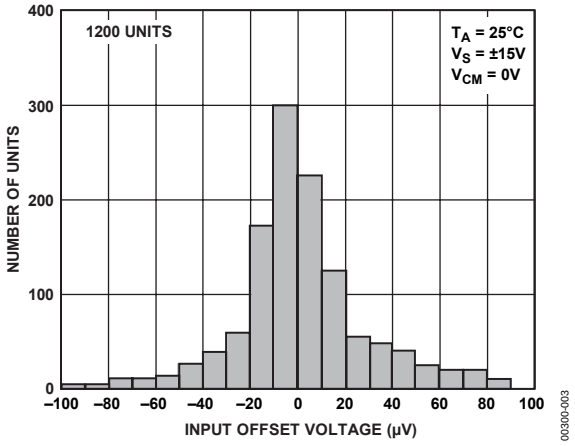

Figure 3. Very Low Offset

Combining precision, low power, and low bias current, the OP297 is ideal for a number of applications, including instrumentation amplifiers, log amplifiers, photodiode preamplifiers, and long term integrators. For a single device, see the OP97; for a quad device, see the OP497.

Rev. F

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SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

@ V_S = ±15 V, T_A = 25°C, unless otherwise noted.

Table 1.

			OP297E			OP297F			OP297G			
Parameter	**Symbol**	**Conditions**	**Min**	**Typ**	**Max**	**Min**	**Typ**	**Max**	**Min**	**Typ**	**Max**	**Unit**
Input Offset Voltage	V_{OS}			25	50		50	100		80	200	µV
Long-Term Input Voltage Stability				0.1			0.1			0.1		µV/mo
Input Offset Current	I_{OS}	V_{CM} = 0 V		20	100		35	150		50	200	pA
Input Bias Current	I_B	V_{CM} = 0 V		20	±100		35	±150		50	±200	pA
Input Noise Voltage	$e_{n\ p\text{-}p}$	0.1 Hz to 10 Hz		0.5			0.5			0.5		µV p-p
Input Noise Voltage Density	e_n	f_O = 10 Hz		20			20			20		nV/√Hz
		f_O = 1000 Hz		17			17			17		nV/√Hz
Input Noise Current Density	i_n	f_O = 10 Hz		20			20			20		fA/√Hz
Input Resistance Differential Mode	R_{IN}			30			30			30		MΩ
Input Resistance Common-Mode	R_{INCM}			500			500			500		GΩ
Large Signal Voltage Gain	A_{VO}	V_O = ±10 V, R_L = 2 kΩ	2000	4000		1500	3200		1200	3200		V/mV
Input Voltage Range[1]	V_{CM}		±13	±14		±13	±14		±13	±14		V
Common-Mode Rejection	CMRR	V_{CM} = ±13 V	120	140		114	135		114	135		dB
Power Supply Rejection	PSRR	V_S = ±2 V to ±20 V	120	130		114	125		114	125		dB
Output Voltage Swing	V_O	R_L = 10 kΩ	±13	±14		±13	±14		±13	±14		V
		R_L = 2 kΩ	±13	±13.7		±13	±13.7		±13	±13.7		V
Supply Current per Amplifier	I_{SY}	No Load		525	625		525	625		525	625	µA
Supply Voltage	V_S	Operating Range	±2		±20	±2		±20	±2		±20	V
Slew Rate	SR		0.05	0.15		0.05	0.15		0.05	0.15		V/µs
Gain Bandwidth Product	GBWP	A_V = +1		500			500			500		kHz
Channel Separation	CS	V_O = 20 V p-p, f_O = 10 Hz		150			150			150		dB
Input Capacitance	C_{IN}			3			3			3		pF

[1] Guaranteed by CMR test.

@ V_S = ±5 V, −40°C ≤ T_A ≤ +85°C for OP297E/OP297F/OP297G, unless otherwise noted.

Table 2.

			OP297E			OP297F			OP297G			
Parameter	**Symbol**	**Conditions**	**Min**	**Typ**	**Max**	**Min**	**Typ**	**Max**	**Min**	**Typ**	**Max**	**Unit**
Input Offset Voltage	V_{OS}			35	100		80	300		110	400	µV
Average Input Offset Voltage Drift	TCV_{OS}			0.2	0.6		0.5	2.0		0.6	2.0	µV/°C
Input Offset Current	I_{OS}	V_{CM} = 0 V		50	450		80	750		80	750	pA
Input Bias Current	I_B	V_{CM} = 0 V		50	±450		80	±750		80	±750	pA
Large Signal Voltage Gain	A_{VO}	V_O = ±10 V, R_L = 2 kΩ	1200	3200		1000	2500		800	2500		V/mV
Input Voltage Range[1]	V_{CM}		±13	±13.5		±13	±13.5		±13	±13.5		V
Common-Mode Rejection	CMRR	V_{CM} = ±13	114	130		108	130		108	130		dB
Power Supply Rejection	PSRR	V_S = ±2.5 V to ±20 V	114	0.15		108	0.15		108	0.3		dB
Output Voltage Swing	V_O	R_L = 10 kΩ	±13	±13.4		±13	±13.4		±13	±13.4		V
Supply Current per Amplifier	I_{SY}	No Load		550	750		550	750		550	750	µA
Supply Voltage	V_S	Operating Range	± 2.5		±20	±2.5		±20	±2.5		±20	V

[1] Guaranteed by CMR test.

ABSOLUTE MAXIMUM RATINGS

Table 3.

Parameter	Rating
Supply Voltage	±20 V
Input Voltage[1]	±20 V
Differential Input Voltage[1]	40 V
Output Short-Circuit Duration	Indefinite
Storage Temperature Range	
Z Package	−65°C to +175°C
P, S Packages	−65°C to +150°C
Operating Temperature Range	
OP297E (Z)	−40°C to +85°C
OP297F, OP297G (P, S)	−40°C to +85°C
Junction Temperature	
Z Package	−65°C to +175°C
P, S Packages	−65°C to +150°C
Lead Temperature (Soldering, 60 sec)	300°C

[1] For supply voltages less than ±20 V, the absolute maximum input voltage is equal to the supply voltage.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

θ_{JA} is specified for worst-case mounting conditions, that is, θ_{JA} is specified for device in socket for CERDIP and PDIP packages; θ_{JA} is specified for device soldered to printed circuit board for the SOIC package.

Table 4. Thermal Resistance

Package Type	θ_{JA}	θ_{JC}	Unit
8-Lead CERDIP (Z-Suffix)	134	12	°C/W
8-Lead PDIP (P-Suffix)	96	37	°C/W
8-Lead SOIC (S-Suffix)	150	41	°C/W

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.

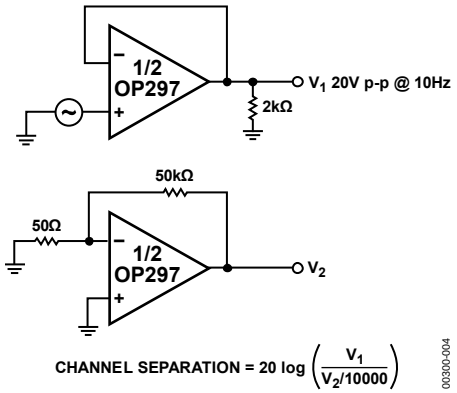


Figure 4. Channel Separation Test Circuit

TYPICAL PERFORMANCE CHARACTERISTICS

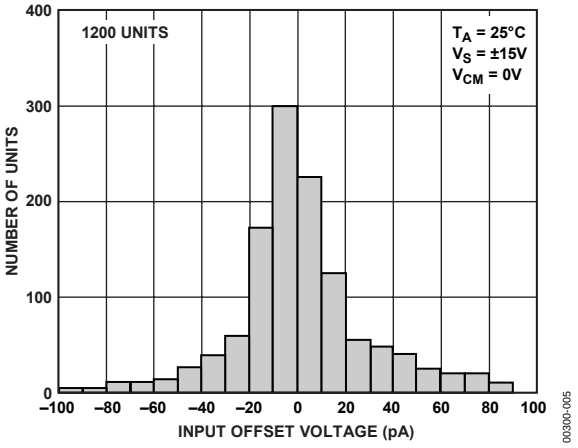


Figure 5. Typical Distribution of Input Offset Voltage

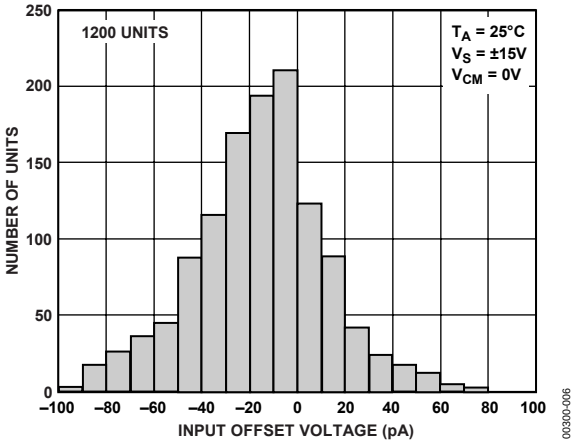


Figure 6. Typical Distribution of Input Bias Current

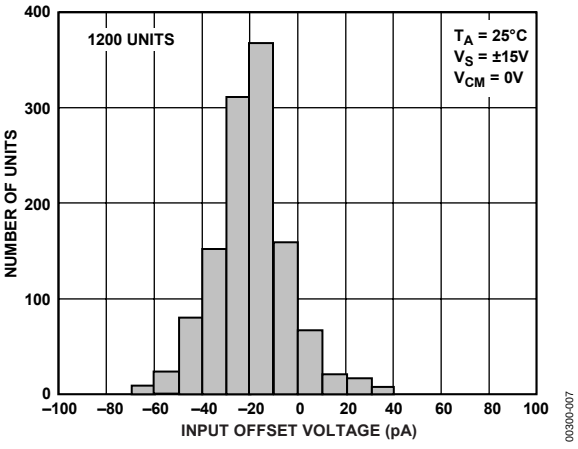


Figure 7. Typical Distribution of Input Offset Current

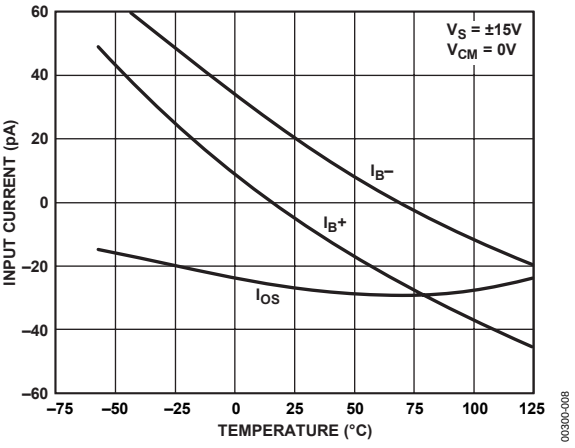


Figure 8. Input Bias, Offset Current vs. Temperature

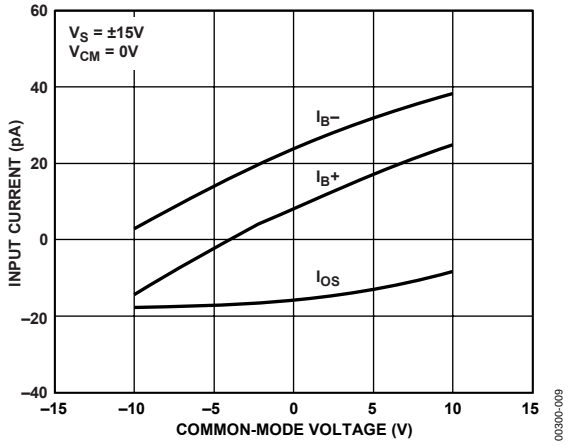


Figure 9. Input Bias, Offset Current vs. Common-Mode Voltage

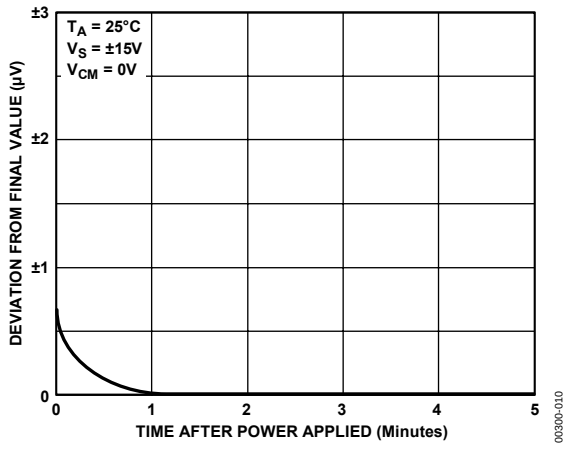


Figure 10. Input Offset Voltage Warm-Up Drift

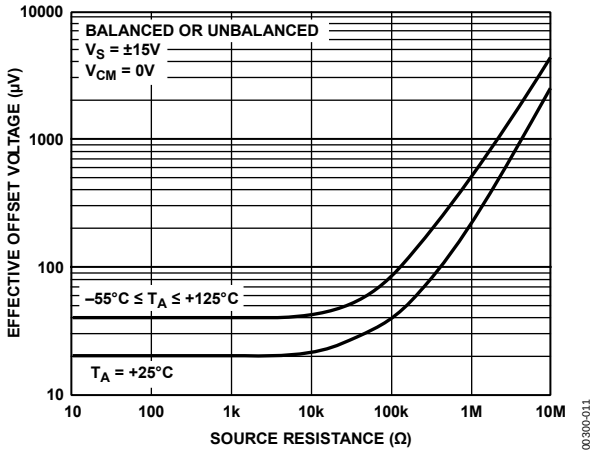


Figure 11. Effective Offset Voltage vs. Source Resistance

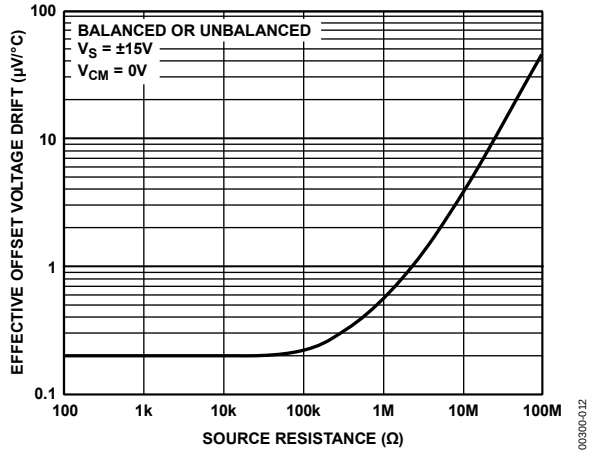


Figure 12. Effective TCV_{OS} vs. Source Resistance

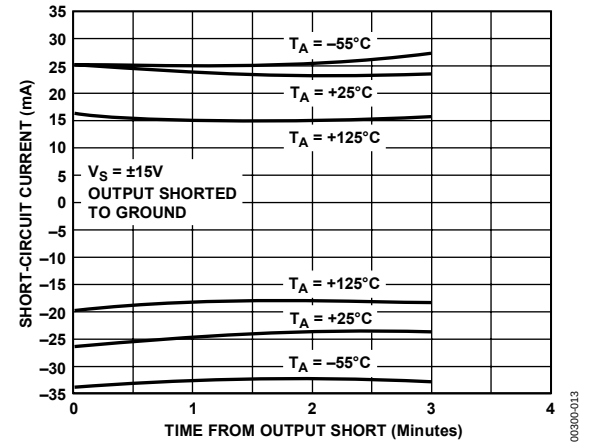


Figure 13. Short-Circuit Current vs. Time, Temperature

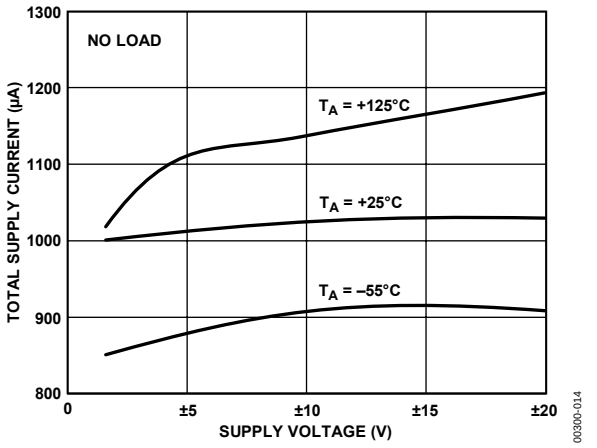


Figure 14. Total Supply Current vs. Supply Voltage

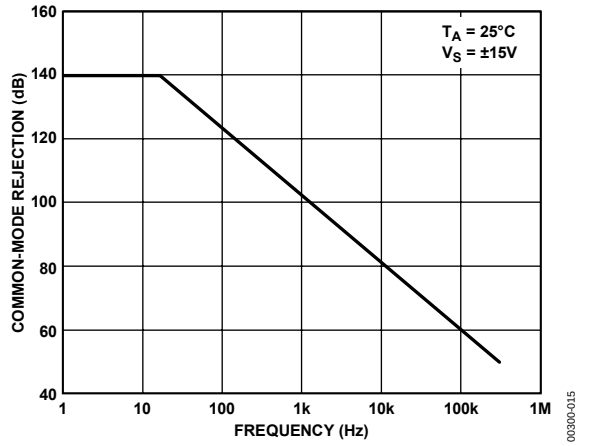


Figure 15. Common-Mode Rejection Frequency

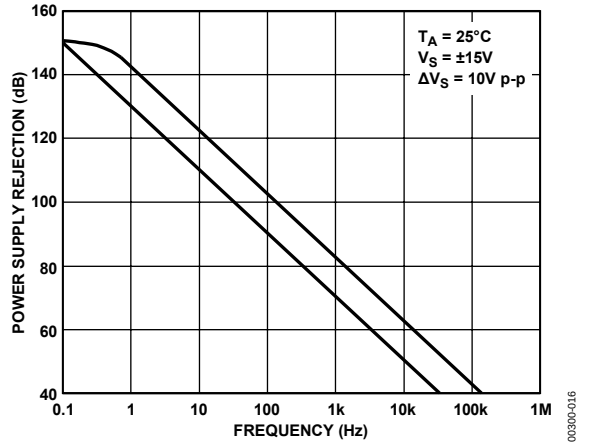


Figure 16. Power Supply Rejection vs. Frequency

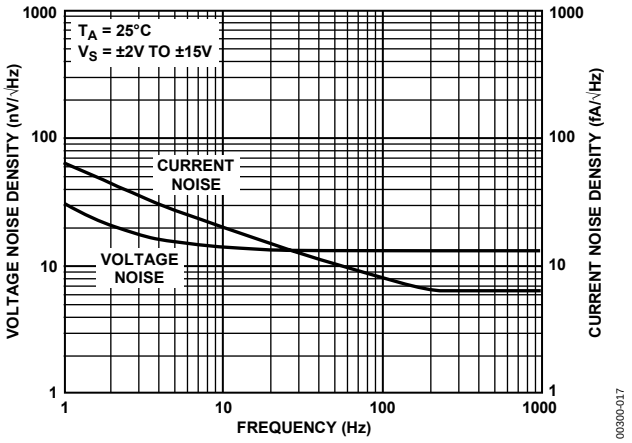


Figure 17. Voltage Noise Density and Current Noise Density vs. Frequency

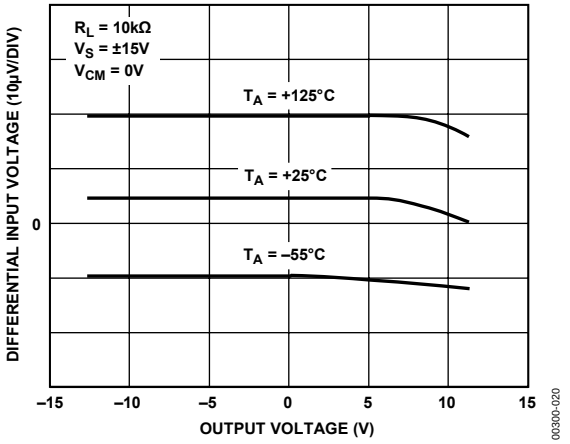


Figure 20. Differential Input Voltage vs. Output Voltage

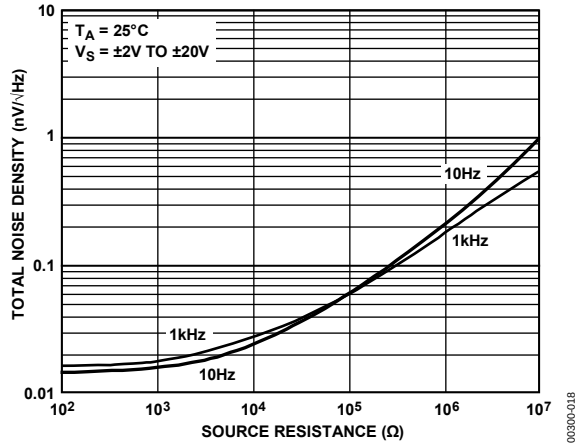


Figure 18. Total Noise Density vs. Source Resistance

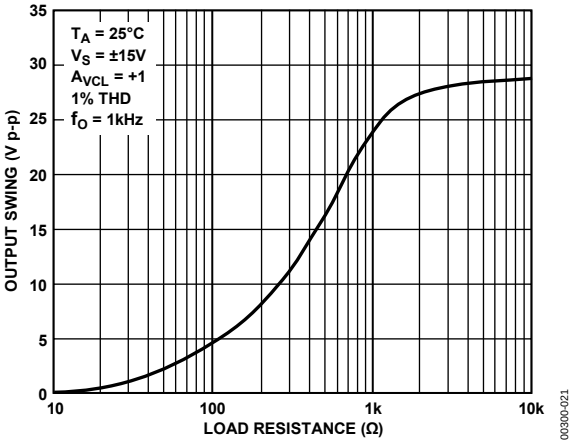


Figure 21. Output Swing vs. Load Resistance

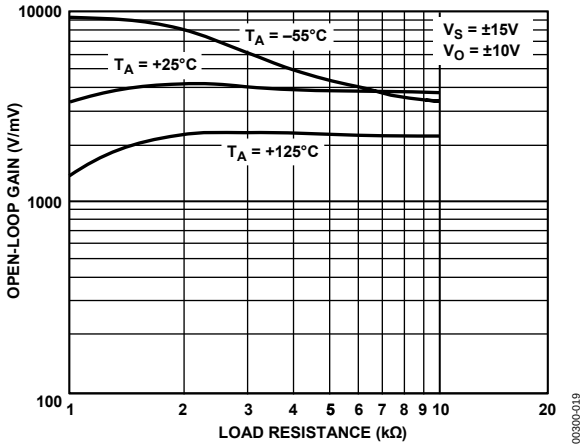


Figure 19. Open-Loop Gain vs. Load Resistance

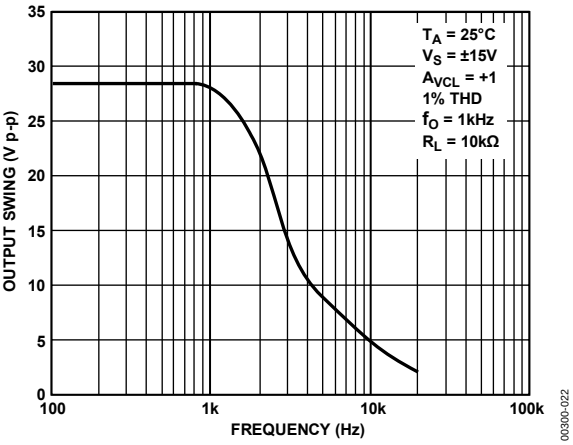


Figure 22. Maximum Output Swing vs. Frequency

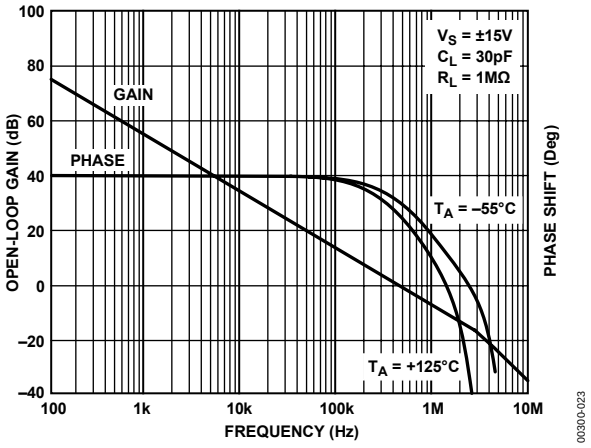


Figure 23. Open-Loop Gain, Phase vs. Frequency

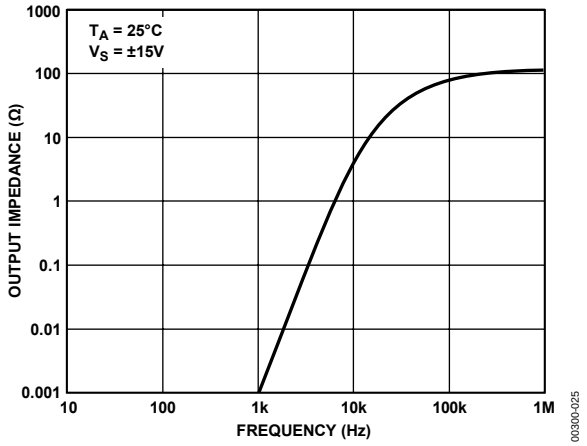


Figure 25. Open-Loop Output Impedance vs. Frequency

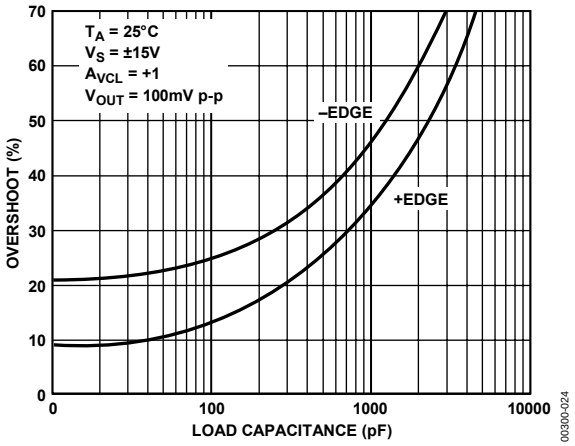


Figure 24. Small Signal Overshoot vs. Load Capacitance

APPLICATIONS INFORMATION

Extremely low bias current over a wide temperature range makes the OP297 attractive for use in sample-and-hold amplifiers, peak detectors, and log amplifiers that must operate over a wide temperature range. Balancing input resistances is unnecessary with the OP297. Offset voltage and TCV_{OS} are degraded only minimally by high source resistance, even when unbalanced.

The input pins of the OP297 are protected against large differential voltage by back-to-back diodes and current-limiting resistors. Common-mode voltages at the inputs are not restricted and can vary over the full range of the supply voltages used.

The OP297 requires very little operating headroom about the supply rails and is specified for operation with supplies as low as 2 V. Typically, the common-mode range extends to within 1 V of either rail. The output typically swings to within 1 V of the rails when using a 10 kΩ load.

AC PERFORMANCE

The ac characteristics of the OP297 are highly stable over its full operating temperature range. Unity gain small signal response is shown in Figure 26. Extremely tolerant of capacitive loading on the output, the OP297 displays excellent response with 1000 pF loads (see Figure 27).

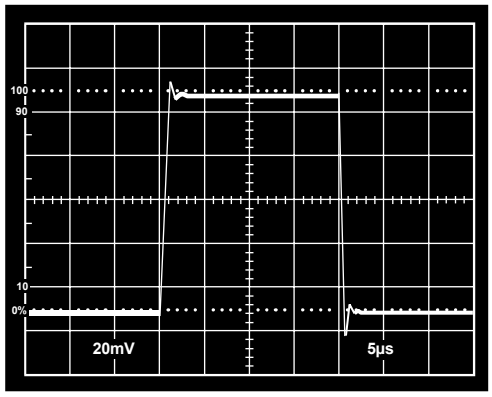


Figure 26. Small Signal Transient Response (C_{LOAD} = 100 pF, A_{VCL} = 1)

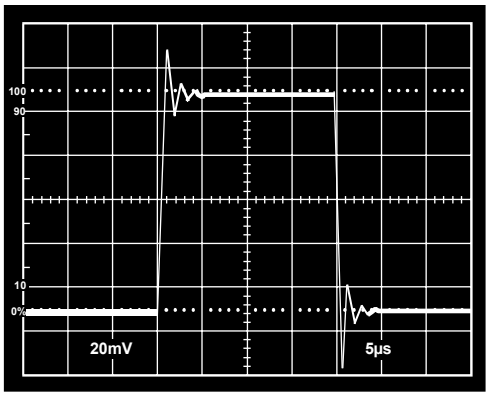


Figure 27. Small Signal Transient Response (C_{LOAD} = 1000 pF, A_{VCL} = 1)

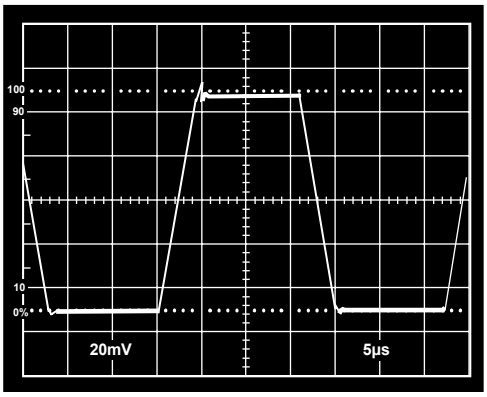


Figure 28. Large Signal Transient Response (A_{VCL} = 1)

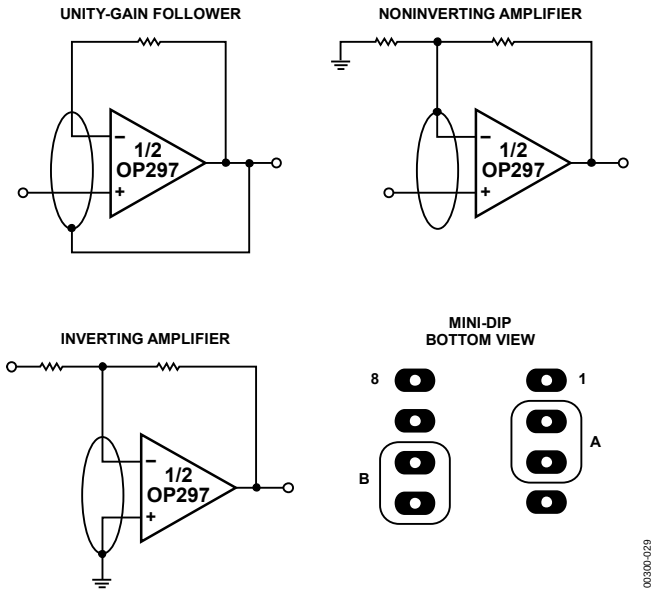


Figure 29. Guard Ring Layout and Considerations

GUARDING AND SHIELDING

To maintain the extremely high input impedances of the OP297, care is taken in circuit board layout and manufacturing. Board surfaces must be kept scrupulously clean and free of moisture. Conformal coating is recommended to provide a humidity barrier. Even a clean PC board can have 100 pA of leakage currents between adjacent traces, so guard rings should be used around the inputs. Guard traces operate at a voltage close to that on the inputs, as shown in Figure 29, to minimize leakage currents. In noninverting applications, the guard ring should be connected to the common-mode voltage at the inverting input. In inverting applications, both inputs remain at ground, so the guard trace should be grounded. Guard traces should be placed on both sides of the circuit board.

OPEN-LOOP GAIN LINEARITY

The OP297 has both an extremely high gain of 2000 V/mV minimum and constant gain linearity. This enhances the precision of the OP297 and provides for very high accuracy in high closed-loop gain applications. Figure 30 illustrates the typical open-loop gain linearity of the OP297 over the military temperature range.

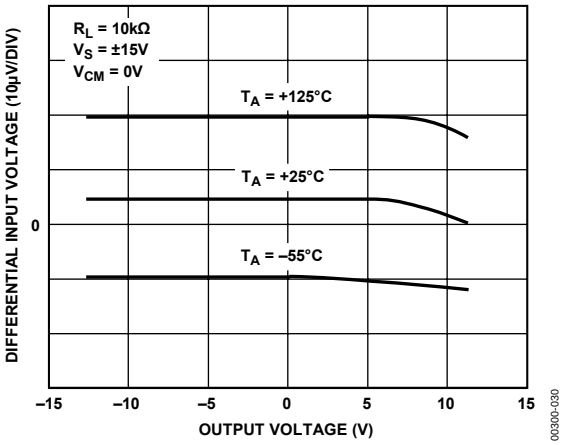


Figure 30. Open-Loop Linearity of the OP297

APPLICATIONS

PRECISION ABSOLUTE VALUE AMPLIFIER

The circuit in Figure 31 is a precision absolute value amplifier with an input impedance of 30 MΩ. The high gain and low TCV_{OS} of the OP297 ensure accurate operation with microvolt input signals. In this circuit, the input always appears as a common-mode signal to the op amps. The CMR of the OP297 exceeds 120 dB, yielding an error of less than 2 ppm.

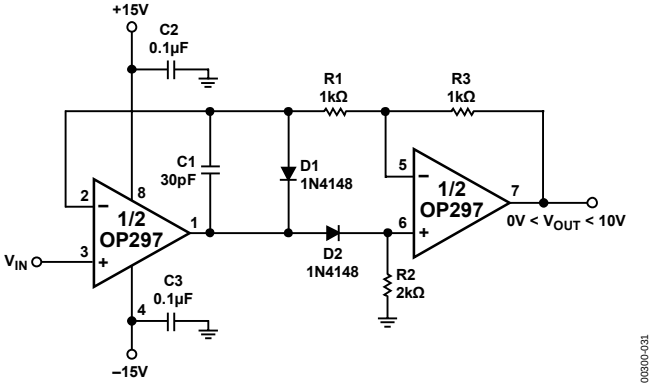


Figure 31. Precision Absolute Value Amplifier

PRECISION CURRENT PUMP

Maximum output current of the precision current pump shown in Figure 32 is ±10 mA. Voltage compliance is ±10 V with ±15 V supplies. Output impedance of the current transmitter exceeds 3 MΩ with linearity better than 16 bits.

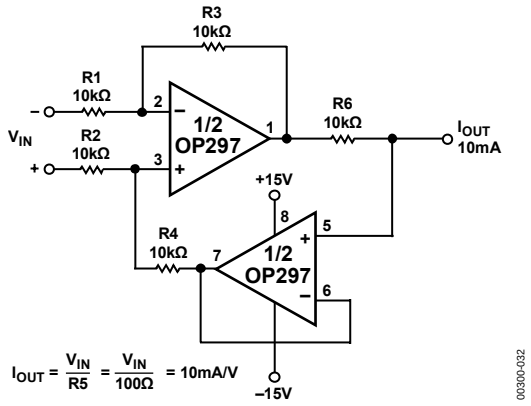


Figure 32. Precision Current Pump

PRECISION POSITIVE PEAK DETECTOR

In Figure 33, the C_H must be of polystyrene, Teflon®, or polyethylene to minimize dielectric absorption and leakage. The droop rate is determined by the size of C_H and the bias current of the OP297.

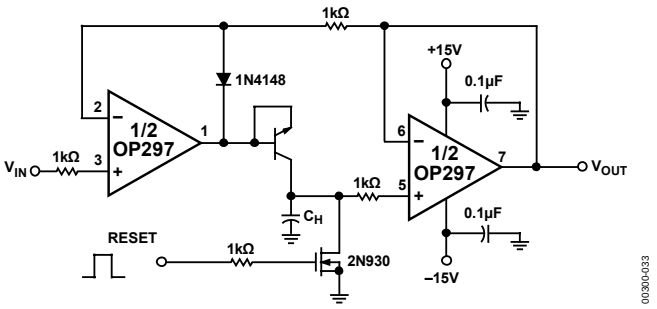


Figure 33. Precision Positive Peak Detector

SIMPLE BRIDGE CONDITIONING AMPLIFIER

Figure 34 shows a simple bridge conditioning amplifier using the OP297. The transfer function is

$$V_{OUT} = V_{REF}\left(\frac{\Delta R}{R+\Delta R}\right)\frac{R_F}{R}$$

The REF43 provides an accurate and stable reference voltage for the bridge. To maintain the highest circuit accuracy, R_F should be 0.1% or better with a low temperature coefficient.

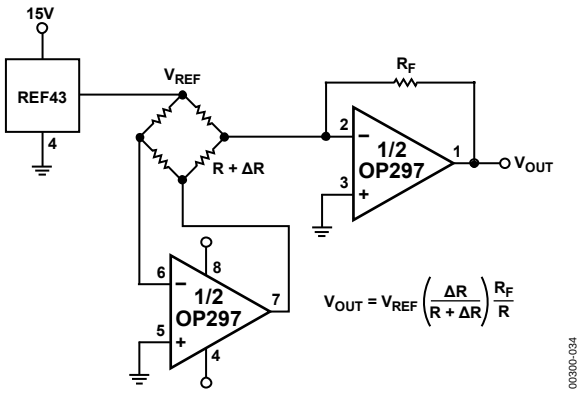


Figure 34. A Simple Bridge Condition Amplifier Using the OP297

NONLINEAR CIRCUITS

Due to its low input bias currents, the OP297 is an ideal log amplifier in nonlinear circuits such as the square and square root circuits shown in Figure 35 and Figure 36. Using the squaring circuit of Figure 35 as an example, the analysis begins by writing a voltage loop equation across Transistor Q1, Transistor Q2, Transistor Q3, and Transistor Q4.

$$V_{T1} ln\left(\frac{I_{IN}}{I_{S1}}\right) + V_{T2} ln\left(\frac{I_{IN}}{I_{S2}}\right) = V_{T3} ln\left(\frac{I_O}{I_{S3}}\right) + V_{T4} ln\left(\frac{I_{REF}}{I_{S4}}\right)$$

All the transistors of the MAT04 are precisely matched and at the same temperature, so the I_S and V_T terms cancel, where

$$2\ ln\ I_{IN} = ln\ I_O + ln\ I_{REF} = ln\ (I_O \times I_{REF})$$

Exponentiating both sides of the equation leads to

$$I_O = \frac{(I_{IN})^2}{I_{REF}}$$

Op Amp A2 forms a current-to-voltage converter, which gives $V_{OUT} = R2 \times I_O$. Substituting (V_{IN}/R1) for I_{IN} and the above equation for I_O yields

$$V_{OUT} = \left(\frac{R2}{I_{REF}}\right)\left(\frac{V_{IN}}{R1}\right)^2$$

A similar analysis made for the square root circuit of Figure 36 leads to its transfer function

$$V_{OUT} = R2\sqrt{\frac{(V_{IN})(I_{REF})}{R1}}$$

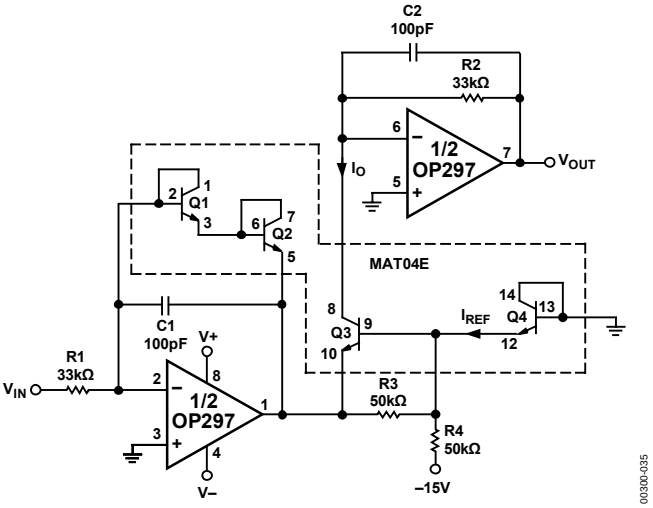


Figure 35. Squaring Amplifier

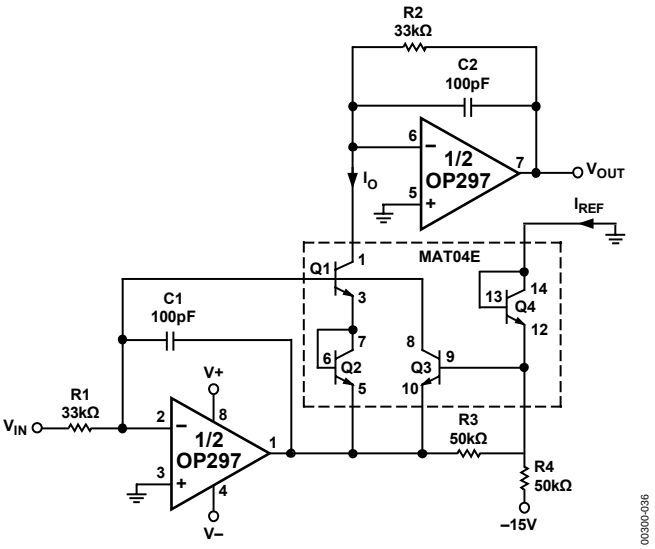


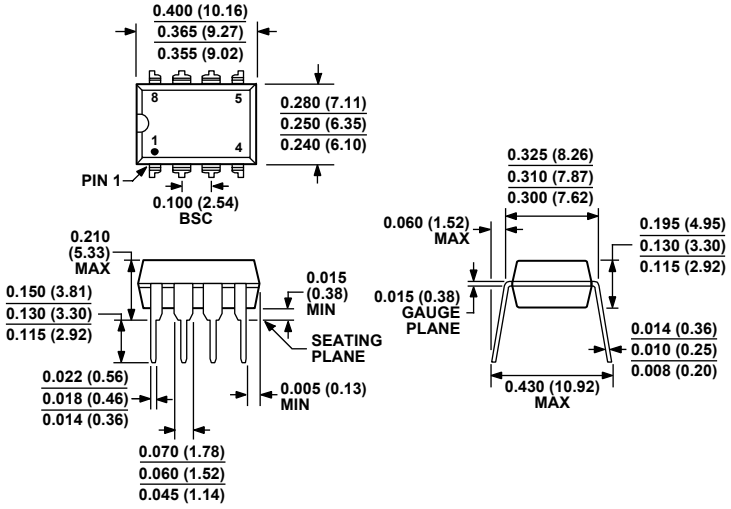
Figure 36. Square Root Amplifier

In these circuits, I_{REF} is a function of the negative power supply. To maintain accuracy, the negative supply should be well regulated. For applications where very high accuracy is required, a voltage reference can be used to set I_{REF}.

An important consideration for the squaring circuit is that a sufficiently large input voltage can force the output beyond the operating range of the output op amp. Resistor R4 can be changed to scale I_{REF} or R1; R2 can be varied to keep the output voltage within the usable range.

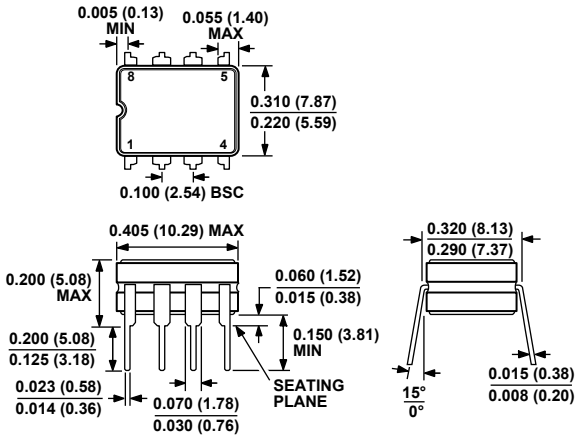
Unadjusted accuracy of the square root circuit is better than 0.1% over an input voltage range of 100 mV to 10 V. For a similar input voltage range, the accuracy of the squaring circuit is better than 0.5%.

OUTLINE DIMENSIONS



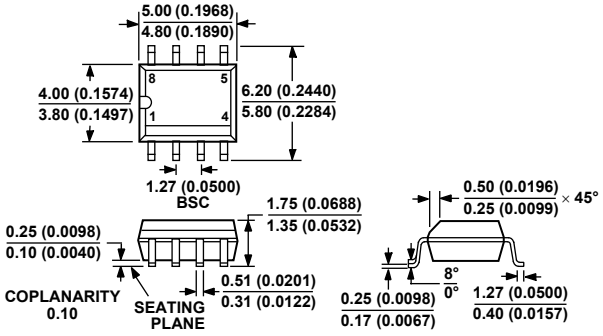
COMPLIANT TO JEDEC STANDARDS MS-001-BA
CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN. CORNER LEADS MAY BE CONFIGURED AS WHOLE OR HALF LEADS.

Figure 37. 8-Lead Plastic Dual In-Line Package [PDIP]
P-Suffix (N-8)
Dimensions shown in inches and (millimeters)



CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 38. 8-Lead Ceramic Dual In-Line Package [CERDIP]
Z-Suffix (Q-8)
Dimensions shown in inches and (millimeters)



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CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 39. 8-Lead Standard Small Outline Package (SOIC)
Narrow Body
S-Suffix (R-8)
Dimensions shown in millimeters and (inches)

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Options
OP297EZ	−40°C to +85°C	8-Lead CERDIP	Q-8
OP297FP	−40°C to +85°C	8-Lead PDIP	N-8
OP297FPZ[1]	−40°C to +85°C	8-Lead PDIP	N-8
OP297FS	−40°C to +85°C	8-Lead SOIC	R-8
OP297FS-REEL	−40°C to +85°C	8-Lead SOIC	R-8
OP297FS-REEL7	−40°C to +85°C	8-Lead SOIC	R-8
OP297FSZ[1]	−40°C to +85°C	8-Lead SOIC	R-8
OP297FSZ-REEL[1]	−40°C to +85°C	8-Lead SOIC	R-8
OP297FSZ-REEL7[1]	−40°C to +85°C	8-Lead SOIC	R-8
OP297GP	−40°C to +85°C	8-Lead PDIP	N-8
OP297GPZ[1]	−40°C to +85°C	8-Lead PDIP	N-8
OP297GS	−40°C to +85°C	8-Lead SOIC	R-8
OP297GS-REEL	−40°C to +85°C	8-Lead SOIC	R-8
OP297GS-REEL7	−40°C to +85°C	8-Lead SOIC	R-8
OP297GSZ[1]	−40°C to +85°C	8-Lead SOIC	R-8
OP297GSZ-REEL[1]	−40°C to +85°C	8-Lead SOIC	R-8
OP297GSZ-REEL7[1]	−40°C to +85°C	8-Lead SOIC	R-8

[1] Z = PB-free part.

NOTES

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C00300-0-2/06(F)